

Notice of References Cited			Application/Control No. 10/628,224	Applicant(s)/Patent Under Reexamination LEE ET AL.	
			Examiner Nhan T. Tran	Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,965,413	11-2005	Wada, Jo	348/376
*	B	US-7,084,919	08-2006	Shibata et al.	348/333.06
*	C	US-6,347,997	02-2002	Armstrong, Brad A.	463/37
*	D	US-6,999,802	02-2006	Kim, Young-Se	348/373
*	E	US-6,549,789	04-2003	Kfouri, Tony N.	455/550.1
*	F	US-6,751,473	06-2004	Goyal et al.	455/556.1
*	G	US-6,980,735	12-2005	Horiguchi, Shigeru	455/556.1
*	H	US-6,295,088	09-2001	Tsukahara et al.	348/333.06
*	I	US-7,038,726	05-2006	Aoki, Hitoshi	348/373
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.